

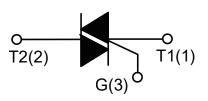
DESCRIPTION:

The BT136S-600F SCR series with the parallel resistor between Gate and Cathode are especially recommended for use on straight hair, igniter, anion generator, etc.



MAIN FEATURES

Symbol	Value	Unit
I _{T(RMS)}	4	А
V _{DRM} /V _{RRM}	600/800	V



ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit		
Storage junction temperature ra	T _{stg}	-40-150	$^{\circ}$ C		
Operating junction temperature	Tj	-40-125	$^{\circ}$ C		
Repetitive peak off-state voltage	V _{DRM}	600/800	V		
Repetitive peak reverse voltage	e(T _j =25℃)	V _{RRM}	600/800	V	
RMS on-state current	TO-252 (Tc=100°C) TO-263 (Tc=95°C)	- I _{T(RMS)}	4	А	
Non repetitive surge peak on-s (full cycle, F=50Hz)	Ітѕм	35	А		
I ² t value for fusing (tp=10ms)	l ² t	6.1	A ² s		
Critical rate of rise of on-state	I - II -III	- dl/dt	50	Λ/μς	
current ($I_G=2 \times I_{GT}$)	IV	10		A/µs	
Peak gate current	I _{GM}	2	Α		
Average gate power dissipation	P _{G(AV)}	0.5	W		
Peak gate power	P _{GM}	5	W		



ELECTRICAL CHARACTERISTICS (T_j=25 °C unless otherwise specified)

Symbol	Test Condition Qu	Quadrant	Value				l loit	
Symbol				Т	D	Е	F	Unit
l _{GT}	V _D =12V	I - II -III	MAV	5	5	10	25	m A
		IV MAX	5	10	25	70	mA	
V _G T		ALL	MAX	1.3				V
V _{GD}	$V_D=V_{DRM}T_j=125$ °C RL=3.3KΩ	ALL	MIN	0.2			V	
1.	I _G =1.2I _{GT}	I -III	MAX	10	20	30	40	mA
I∟		II -IV		15	35	45	60	
Ін	I _T =100mA		MAX	5	15	25	30	mA
dV/dt	V _D =2/3V _{DRM} Gate Open T _j =125℃		MIN	20	50	100	150	V/µs
(dV/dt)c	(dI/dt)c=1.7A/ms T _j =125℃		MIN	0.1	0.1	0.5	5	V/µs

STATIC CHARACTERISTICS

Symbol	Parameter		Value(MAX)	Unit
V _{TM}	I _{TM} =5.5A tp=380μs	T _j =25℃	1.6	V
I _{DRM}	V _D =V _{DRM} V _R =V _{RRM}	T _j =25℃	5	μA
I _{RRM}		T _j =125℃	0.5	mA

THERMAL RESISTANCES

Symbol	Parameter		Value	Unit
R _{th(j-c)} ju	junction to case(AC)	TO-252 2.8		°C/W
		TO-263	3.8	
Rth(j-a)	junction to ambient	TO-252 70		°C/W
		TO-263	45	



FIG.1: Maximum power dissipation versus RMS on-state current

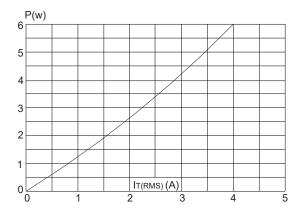


FIG.3: Surge peak on-state current versus number of cycles

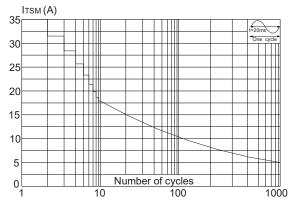


FIG.2: RMS on-state current versus ambient temperature (printed circuit board FR4, copper thickness: 35µm)

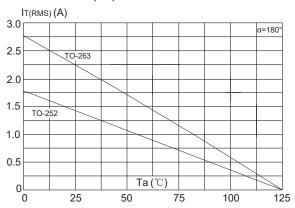


FIG.4: On-state characteristics (maximum values)

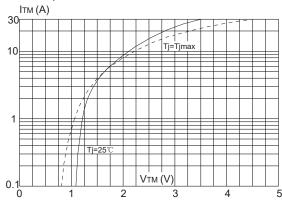




FIG.5: Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp<20ms and corresponding value of I^2t (I - II - III : dI/dt < 50A/ μ s; IV:dI/dt < 10A/ μ s)

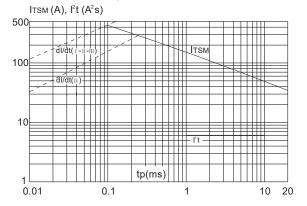


FIG.7: Relative variations of holding current versus junction temperature

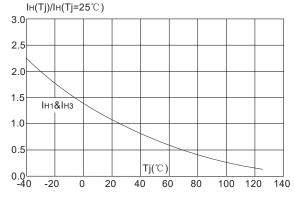


FIG.6: Relative variations of gate trigger current versus junction temperature

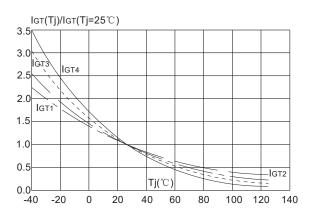
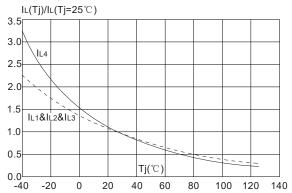


FIG.8: Relative variations of latching current versus junction temperature





SOLDERING PARAMETERS

Reflow Condition		Pb-Free assembly		
		(see figure at right)		
	-Temperature Min	+150°C		
	(T _{s(min)})			
Pre Heat	-Temperature	+200℃		
	$Max(T_{s(max)})$	200 0		
	-Time (Min to Max) (ts)	60-180 secs.		
Average ra	mp up rate			
	emp (T _L)to peak)	3°C/sec. Max		
T _{s(max)} to T _L	- Ramp-up Rate	3℃/sec. Max		
	-Temperature(T _L)	+217℃		
Reflow	(Liquidus)	7217 C		
	-Temperature(t∟)	60-150 secs.		
Peak Temp) (T _p)	+260(+0/-5)°C		
Time within	n 5°Cof actual	00.40		
Peak Temp	$o(t_p)$	20-40secs.		
Ramp-dow	n Rate	6°C/sec. Max		
Time 25°C	to Peak Temp (T _P)	8 min. Max		
Do not exc	eed	+260℃		

